

# Search Notes



Application/Control No.

10/775,473

Examiner

Mark H. Paschall

Applicant(s)/Patent under Reexamination

CHEN ET AL.

Art Unit

3742

## SEARCHED

Class	Subclass	Date	Examiner
219	447 505 490	8-3-05	m
	499 202-205		
73	31.05		
	31.06 23.2		
374	141		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Pat Enclose	8/3/05	2